Application/Control No. Applicant(s)/Patent Under Reexamination 10/749,045 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1732 Mathieu D. Vargot **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY Choi et al. 264/1.24 US-6,699,409 03-2004 Α 264/1.1 US-6,776,931 08-2004 Nishigaki, Yoshiki В С US-US-D US-Ė US-F US-G US-Н US-١ US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х